

# 4A/2A Dual Channel Synchronous Step-Down Switcher with Integrated FET

Check for Samples: TPS54495

### **FEATURES**

- D-CAP2™ Control Mode
  - Fast Transient Response
  - No External Parts Required For Loop Compensation
  - Compatible with Ceramic Output Capacitors
- Wide Input Voltage Range: 4.5 V to 18 V
- Output Voltage Range: 0.76 V to 7 V
- Highly Efficient Integrated FETs Optimized for Low Duty Cycle Applications
  - 90 mΩ (High Side) and 60 mΩ (Low Side)
- High Initial Reference Accuracy
- Supports Constant 4 A CH1 and 2 A CH2 Load Current
- Low-Side r<sub>DS(on)</sub> Loss-Less Current Sensing
- Adjustable Soft Start
- Non-Sinking Pre-Biased Soft Start
- 700 kHz Switching Frequency
- Cycle-by-Cycle Over-Current Limit Control
- OCL/UVLO/TSD Protections
- Hiccup Timer for Overload Protection
- Adaptive Gate Drivers with Integrated Boost PMOS Switch
- OCP Constant Due To Thermally Compensated r<sub>DS(on)</sub> with 4000ppm/°C
- 16-Pin HTSSOP, 16-Pin VQFN
- Auto-Skip Eco-mode™ for High Efficiency at Light Load

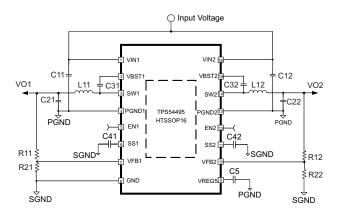
### **APPLICATIONS**

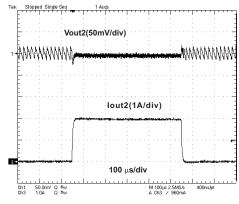
- Point-of-Load Regulation in Low Power Systems for Wide Range of Applications
  - Digital TV Power Supply
  - Networking Home Terminal
  - Digital Set Top Box (STB)
  - DVD Player/Recorder
  - Gaming Consoles and Other

### DESCRIPTION

The TPS54495 is a dual, adaptive on-time D-CAP2™ mode synchronous buck converter. The TPS54495 enables system designers to complete the suite of various end equipment's power bus regulators with a cost effective, low component count, and low standby current solution. The main control loops of the TPS54495 use the D-CAP2™ mode control which provides a very fast transient response with no external compensation components. The adaptive ontime control supports seamless transition between PWM mode at higher load conditions and Ecomode<sup>™</sup> operation at light loads. Eco-mode<sup>™</sup> allows the TPS54495 to maintain high efficiency during lighter load conditions. The TPS54495 is able to adapt to both low equivalent series resistance (ESR) output capacitors such as POSCAP or SP-CAP, and ultra-low ESR, ceramic capacitors. The device provides convenient and efficient operation with input voltages from 4.5V to 18V.

The TPS54495 is available in a 4.4 mm × 5 mm 16-pin TSSOP (PWP) package and 4 mm x 4 mm 16-pin VQFN (RSA), and is designed to operate for an ambient temperature range from -40°C to 85°C.





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D-CAP2, Eco-mode, Eco-Mode are trademarks of Texas Instruments.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### ORDERING INFORMATION(1)

T <sub>A</sub>	PACKAGE <sup>(2)</sup> (3)	ORDERING PART NUMBER	PINS	OUTPUT SUPPLY	
	PWP	TPS54495PWPR	16	Tape-and-Reel	
4000 1 - 0500	PVVP	TPS54495PWP	16	Tube	
–40°C to 85°C	DCA	TPS54495RSAR	16	Tone and Dool	
	RSA	TPS54495RSAT	16	Tape-and-Reel	

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com
- (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.
- (3) All packaging options have Cu NIPDAU lead/ball finish.

### **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted) (1) (2)

			VALUE	UNIT
		VIN1, VIN2, EN1, EN2	-0.3 to 20	
		VBST1, VBST2	-0.3 to 26	
		VBST1, VBST2 (10ns transient)	-0.3 to 28	
	Input voltage range	VBST1-SW1 , VBST2-SW2	-0.3 to 6.5	V
		VFB1, VFB2	-0.3 to 6.5	
		SW1, SW2	-2 to 20	
		SW1, SW2 (10ns transient)	-3 to 22	
	Outside a literature	VREG5, SS1, SS2	-0.3 to 6.5	
	Output voltage range	PGND1, PGND2	-0.3 to 0.3	V
	Electronic Confloring	Human Body Model (HBM)	2	kV
	Electrostatic discharge	Charged Device Model (CDM)	500	V
T <sub>A</sub>	Operating ambient temper	erature range	-40 to 85	°C
T <sub>STG</sub>	Storage temperature range	ge	-55 to 150	°C
$T_{J}$	Junction temperature ran	ge	-40 to 150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" are not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### (2) All voltages are with respect to IC GND terminal.

#### THERMAL INFORMATION

	THERMAL METRIC <sup>(1)</sup>	TPS:	UNITS	
	THERMAL METRIC '	PWP (16) PINS	RSA (16) PINS	UNITS
$\theta_{JA}$	Junction-to-ambient thermal resistance	41.4	32.8	
$\theta_{\text{JCtop}}$	Junction-to-case (top) thermal resistance	27.8	35.4	
$\theta_{JB}$	Junction-to-board thermal resistance	23.2	9.9	°C/M
$\Psi_{JT}$	Junction-to-top characterization parameter	0.9	0.4	°C/W
ΨЈВ	Junction-to-board characterization parameter	23.0	10.0	
$\theta_{\text{JCbot}}$	Junction-to-case (bottom) thermal resistance	3.5	1.6	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



### RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

		VALU	MIN         MAX           4.5         18           -0.1         24	
		MIN	MAX	UNIT
Supply input voltage ran	ge VIN1, VIN2	4.5	18	V
	VBST1, VBST2	-0.1	24	
	VBST1, VBST2 (10ns transient)	-0.1	27	
	VBST1-SW1, VBST2-SW2	-0.1	5.7	
Input voltage range	VFB1, VFB2	-0.1	-0.1 5.7	V
	EN1, EN2	-0.1	18	
	SW1, SW2	-1.0	18	
	SW1, SW2 (10ns transient)	-3	21	
	VREG5, SS1, SS2	-0.1	5.7	
Output voltage range	PGND1, PGND2	-0.1	0.1	V
	VO1, VO2	0.76	7.0	
T <sub>A</sub> Operating free-air tempe	rature	-40	85	°C
T <sub>J</sub> Operating Junction Tem	perature	-40	150	°C

# **ELECTRICAL CHARACTERISTICS**(1)

over recommended free-air temperature range, VIN = 12 V (unless otherwise noted)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY C	URRENT					
I <sub>IN</sub>	VIN supply current	$T_A = 25^{\circ}\text{C}$ , EN1 = EN2 = 5 V, VFB1 = VFB2 = 0.8 V				μΑ
I <sub>VINSDN</sub>	VIN shutdown current	T <sub>A</sub> = 25°C, EN1 = EN2 = L after H		15	20	μA
FEEDBACI	K VOLTAGE					
$V_{VFBTHLx}$	VFBx threshold voltage	T <sub>A</sub> = 25°C, CH1 = 3.3 V, CH2 = 1.5 V	758	765	773	mV
TC <sub>VFBx</sub>	Temperature coefficient	On the basis of 25°C <sup>(2)</sup>	-115		115	ppm/°C
I <sub>VFBx</sub>	VFBx Input Current	VFBx = 0.8 V, T <sub>A</sub> = 25°C	-0.4	0.2	0.4	μA
VREG5 OU	ITPUT		1		,	
$V_{VREG5}$	VREG5 output voltage	T <sub>A</sub> = 25°C, 6 V < VIN1 < 18 V, I <sub>VREG</sub> = 5 mA		5.5		V
I <sub>VREG5</sub>	Output current	VIN1 = 6 V, VREG5 = 4.0 V, $T_A = 25^{\circ}C^{(2)}$		75		mA
MOSFETs			1		,	
r <sub>DS(on)H</sub>	High side switch resistance	$T_A = 25^{\circ}C$ , VBSTx-SWx = 5.5 V <sup>(2)</sup>		90		mΩ
r <sub>DS(on)L</sub>	Low side switch resistance	T <sub>A</sub> = 25°C <sup>(2)</sup>		60		mΩ
ON-TIME T	IMER CONTROL		*		*	
T <sub>ON1</sub>	SW1 On Time	SW1 = 12 V, VO1 = 1.2 V		165		ns
T <sub>ON2</sub>	SW2 On Time	SW2 = 12 V, VO2 = 1.2 V		165		ns
T <sub>OFF1</sub>	SW1 Min off time	T <sub>A</sub> = 25°C, VFB1 = 0.7 V <sup>(2)</sup>		220		ns
T <sub>OFF2</sub>	SW2 Min off time	$T_A = 25^{\circ}C$ , VFB2 = 0.7 $V^{(2)}$		220		ns
SOFT STA	RT	·	•		· · · · · ·	
I <sub>SSC</sub>	SSx charge current	VSSx = 0.5 V, T <sub>A</sub> = 25°C	-8.4	-8.0	-7.6	μA
TC <sub>ISSC</sub>	I <sub>SSC</sub> temperature coefficient	On the basis of 25°C <sup>(2)</sup>	-5		4	nA/°C
I <sub>SSD</sub>	SSx discharge current	VSSx = 0.5 V	3	7	10	mA

<sup>(1)</sup> x means either 1 or 2, that is VFBx means VFB1 or VFB2.

<sup>(2)</sup> Specified by design. Not production tested.



# ELECTRICAL CHARACTERISTICS(1) (continued)

over recommended free-air temperature range, VIN = 12 V (unless otherwise noted)

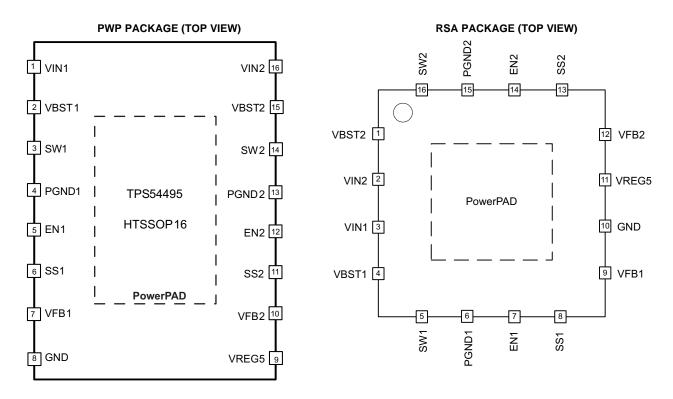
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
				•	
VDECE IN I O three hold	VREG5 rising				
VREG5 UVLO triresnoid	Hysteresis		0.6		V
ESHOLDs					
ENx H-level threshold voltage		2.0			V
ENx L-level threshold voltage				0.4	V
ENx input resistance	ENx = 12V	225	450	900	kΩ
LIMITs					
CH1 Current limit	$L_{OUT1} = 2.2  \mu H^{(3)}$	4.5	5.7	7.0	Α
CH1 Current limit	L <sub>OUT2</sub> = 1.5 μH <sup>(3)</sup>	2.8	3.9	5.0	Α
NDERVOLTAGE AND OVERVOLTAGE	PROTECTION (UVP, OVP)				
Output UVP trip threshold	measured on VFBx	63%	68%	73%	
Output UVP delay time			1.5		ms
Output UVP enable delay	UVP enable delay / softstart time	x 1.4	x 1.7	x 2.0	
SHUTDOWN					
The area of a british area that and	Shutdown temperature <sup>(3)</sup>		155		°C
i nermai snutdown threshold	Hysteresis <sup>(3)</sup>		25		- J
	VREG5 UVLO threshold  ESHOLDS  ENx H-level threshold voltage  ENx L-level threshold voltage  ENx input resistance  LIMITS  CH1 Current limit  CH1 Current limit  NDERVOLTAGE AND OVERVOLTAGE  Output UVP trip threshold  Output UVP delay time  Output UVP enable delay	VREG5 UVLO threshold  VREG5 rising Hysteresis  ESHOLDS  ENx H-level threshold voltage  ENx L-level threshold voltage  ENx input resistance  ENx = 12V  LIMITS  CH1 Current limit  CH1 Current limit  LOUT1 = 2.2 µH(3)  CH1 Current limit  LOUT2 = 1.5 µH(3)  NDERVOLTAGE AND OVERVOLTAGE PROTECTION (UVP, OVP)  Output UVP trip threshold  Output UVP delay time  Output UVP enable delay  UVP enable delay / softstart time  SHUTDOWN  Shutdown temperature (3)	VREG5 UVLO threshold  VREG5 rising Hysteresis  ESHOLDs  ENx H-level threshold voltage  ENx L-level threshold voltage  ENx input resistance  ENx = 12V  225  LIMITS  CH1 Current limit  L <sub>OUT1</sub> = 2.2 μH <sup>(3)</sup> CH1 Current limit  L <sub>OUT2</sub> = 1.5 μH <sup>(3)</sup> 2.8  NDERVOLTAGE AND OVERVOLTAGE PROTECTION (UVP, OVP)  Output UVP trip threshold  Measured on VFBx  Output UVP delay time  Output UVP enable delay  UVP enable delay / softstart time  x 1.4  SHUTDOWN  Shutdown temperature <sup>(3)</sup>	$VREG5 \ UVLO \ threshold \qquad VREG5 \ rising \qquad 3.83$ $Hysteresis \qquad 0.6$ $ESHOLDS$ $ENx \ H-level \ threshold \ voltage \qquad 2.0$ $ENx \ L-level \ threshold \ voltage \qquad ENx = 12V \qquad 225  450$ $LIMITS$ $CH1 \ Current \ limit \qquad L_{OUT1} = 2.2 \ \mu H^{(3)} \qquad 4.5  5.7$ $CH1 \ Current \ limit \qquad L_{OUT2} = 1.5 \ \mu H^{(3)} \qquad 2.8  3.9$ $NDERVOLTAGE \ AND \ OVERVOLTAGE \ PROTECTION \ (UVP, OVP)$ $Output \ UVP \ trip \ threshold \qquad measured \ on \ VFBx \qquad 63\%  68\%$ $Output \ UVP \ delay \ time \qquad 1.5$ $Output \ UVP \ enable \ delay \qquad UVP \ enable \ delay / \ softstart \ time \qquad x \ 1.4  x \ 1.7$ $SHUTDOWN$ $Thermal \ shutdown \ threshold \qquad Shutdown \ temperature \ (3)$ $Shutdown \ temperature \ (3)$	$VREG5 \ UVLO \ threshold$ $VREG5 \ rising$ $Hysteresis$ $0.6$ $ESHOLDs$ $ENx \ H-level \ threshold \ voltage$ $ENx \ H-level \ threshold \ voltage$ $ENx \ L-level \ threshold \ voltage$ $ENx \ = 12V$ $225 \ 450 \ 900$ $LIMITS$ $CH1 \ Current \ limit$ $L_{OUT1} = 2.2 \ \mu H^{(3)}$ $CH1 \ Current \ limit$ $L_{OUT2} = 1.5 \ \mu H^{(3)}$ $2.8 \ 3.9 \ 5.0$ $NDERVOLTAGE \ AND \ OVERVOLTAGE \ PROTECTION \ (UVP, \ OVP)$ $Output \ UVP \ trip \ threshold$ $Measured \ on \ VFBx$ $Output \ UVP \ delay \ time$ $Output \ UVP \ delay \ time$ $Output \ UVP \ enable \ delay$ $UVP \ enable \ delay \ / \ softstart \ time$ $x \ 1.4 \ x \ 1.7 \ x \ 2.0$ $SHUTDOWN$ $Shutdown \ temperature^{(3)}$ $155$

<sup>(3)</sup> Specified by design. Not production tested.

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### **DEVICE INFORMATION**



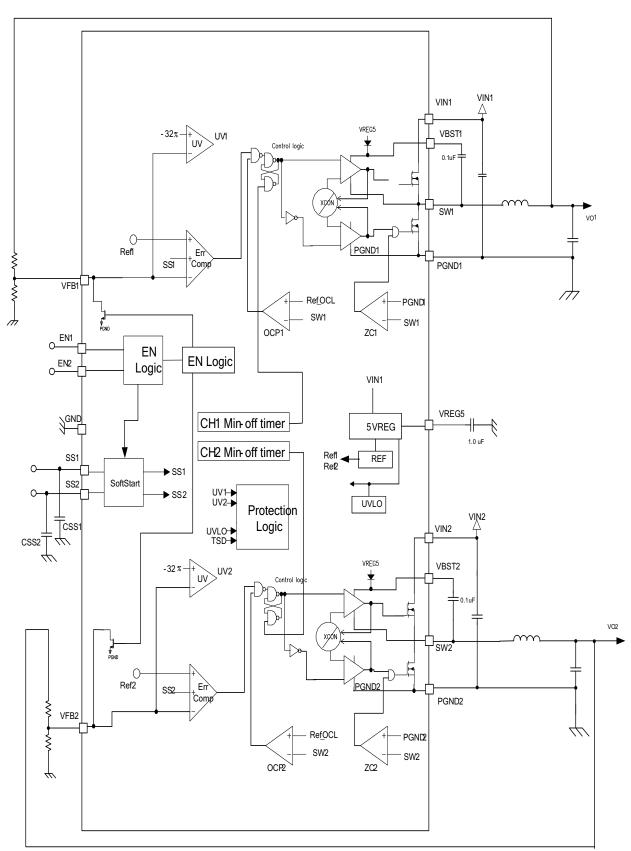
# PIN FUNCTIONS(1)

	PIN		1/0	DESCRIPTION					
NAME	PWP	RSA	1/0	DESCRIPTION					
VIN1	1	3	I	Power inputs and connects to both high side NFET drains.					
VIN2	16	2	I	Supply Input for 5.5 V linear regulator.					
VBST1	2	4	I	Supply input for high-side NFET gate drive circuit. Connect 0.1 µF ceramic					
VBST2	15	1	ļ	capacitor between VBSTx and SWx pins. An internal diode is connected between VREG5 and VBSTx					
SW1	3	5	I/O	Switch node connections for both the high-side NFETs and low–side NFETs.					
SW2	14	16	I/O	Input of current comparator.					
PGND1	4 6		I/O	Once destruction (colors ide MOOFFT) best of control of					
PGND2	13	15	I/O	Ground returns for low-side MOSFETs. Input of current comparator.					
EN1	5	7	I	Foods Bull link to continuous and a					
EN2	12	14	I	Enable. Pull High to enable according converter.					
SS1	6	8	0	Soft-Start Programming Pin. Connect Capacitor from SSx pin to GND to					
SS2	11	13	0	program Soft-Start time.					
VFB1	7	9	I	D. O.A.D.C. for all and investor Comments and the state of the state o					
VFB2	10	12	I	D-CAP2 feedback inputs. Connect to output voltage with resistor divider.					
GND	8	10	I/O	Signal GND. Connect sensitive SSx and VFBx returns to GND at a single point.					
VREG5	9	11	0	Output of 5.5 V linear regulator. Bypass to GND with a high-quality ceramic capacitor of at least 1 µF. VREG5 is active when VIN1 is added.					
Exposed Thermal Pad	Back side	Back side	I/O	Thermal pad of the package. Must be soldered to achieve appropriate dissipation. Must be connected to GND.					

(1) x means either 1 or 2, that is. VFBx means VFB1 or VFB2.



### **FUNCTIONAL BLOCK DIAGRAM**





#### **OVERVIEW**

The TPS54495 is a 4A/2A dual synchronous step-down (buck) converter with two integrated N-channel MOSFETs for each channel. It operates using D-CAP2™ control mode. The fast transient response of D-CAP2™ control reduces the required output capacitance to meet a specific level of performance. Proprietary internal circuitry allows the use of low ESR output capacitors including ceramic and special polymer types.

#### **DETAILED DESCRIPTION**

#### **PWM Operation**

The main control loop of the TPS54495 is an adaptive on-time pulse width modulation (PWM) controller that supports a proprietary D-CAP2™ control mode. D-CAP2™ control combines constant on-time control with an internal compensation circuit for pseudo-fixed frequency and low external component count configuration with both low ESR and ceramic output capacitors. It is stable even with virtually no ripple at the output.

At the beginning of each cycle, the high-side MOSFET is turned on. This MOSFET is turned off when the internal timer expires. This timer is set by the converter's input voltage, VINx, and the output voltage, VOx, to maintain a pseudo-fixed frequency over the input voltage range hence it is called adaptive on-time control. The timer is reset and the high-side MOSFET is turned on again when the feedback voltage falls below the nominal output voltage. An internal ramp is added to the reference voltage to simulate output voltage ripple, eliminating the need for ESR induced output ripple from D-CAP<sup>TM</sup> control.

#### **PWM Frequency and Adaptive On-Time Control**

TPS54495 uses an adaptive on-time control scheme and does not have a dedicated on board oscillator. The TPS54495 runs with a pseudo-fixed frequency of 700 kHz by using the input voltage and output voltage to set the on-time timer. The on-time is inversely proportional to the input voltage and proportional to the output voltage, therefore, when the duty ratio is VOx/VINx, the frequency is constant.

#### Auto-Skip Eco-Mode™ Control

The TPS54495 is designed with Auto-Skip Eco-mode<sup>TM</sup> to increase light load efficiency. As the output current decreases from heavy load condition, the inductor current also reduces and eventually comes to the point where its ripple valley touches the zero level, which is the boundary between continuous conduction and discontinuous conduction modes. The rectifying MOSFET is turned off when zero inductor current is detected. As the load current further decreases the converter runs into discontinuous conduction mode. The on-time is kept almost the same as it was in the continuous conduction mode because it takes longer to discharge the output capacitor with smaller load current to the nominal output voltage. The transition point to the light load operation  $I_{Ox(LL)}$  current can be estimated with Equation 1 with 700-kHz used as  $f_{SW}$ .

$$I_{Ox(LL)} = \frac{1}{2 \times L1x \times f_{SW}} \times \frac{(V_{INx} - V_{Ox}) \times V_{Ox}}{V_{INx}}$$
(1)

### **Soft Start and Pre-Biased Soft Start**

The soft start time is adjustable. When the ENx pin becomes high,  $8-\mu A$  current begins charging the capacitor which is connected from the SSx pin to GND. Smooth control of the output voltage is maintained during start up. The equation for the slow start time is shown in Equation 2. VFBx voltage is 0.765-V and SSx pin source current is  $8-\mu A$ .

$$T_{SS}(ms) = \frac{C4x(nF) \times VFBx(V)}{I_{SS}(\mu A)} = \frac{C4x(nF) \times 0.765 V}{8 \mu A}$$
(2)

The TPS54495 contains a unique circuit to prevent current from being pulled from the output during startup if the output is pre-biased. When the soft-start commands a voltage higher than the pre-bias level (internal soft start becomes greater than internal feedback voltage VFBx), the controller slowly activates synchronous rectification by starting the first low side FET gate driver pulses with a narrow on-time. It then increments that on-time on a cycle-by-cycle basis until it coincides with the time dictated by (1-D), where D is the duty cycle of the converter. This scheme prevents the initial sinking of the pre-biased output, and ensures that the output voltage (VOx) starts and ramps up smoothly into regulation from pre-biased startup to normal mode operation.



### **Current Sensing and Over-Current Protection**

The output over-current protection (OCP) is implemented using a cycle-by-cycle valley detection control circuit. The switch current is monitored by measuring the low-side FET switch voltage between the SWx and PGNDx pins. This voltage is proportional to the switch current and the on-resistance of the FET. To improve the measurement accuracy, the voltage sensing is temperature compensated.

During the on-time of the high-side FET switch, the switch current increases at a linear rate determined by VINx, VOx, the on-time and the output inductor value. During the on-time of the low-side FET switch, this current decreases linearly. The average value of the switch current is the load current  $I_{Ox}$ . If the sensed voltage on the low-side FET is above the voltage proportional to the current limit, the converter keeps the low-side switch on until the measured voltage falls below the voltage corresponding to the current limit and a new switching cycle begins. In subsequent switching cycles, the on-time is set to the value determined for CCM and the current is monitored in the same manner.

Important considerations for this type of over-current protection: The load current is one half of the peak-to-peak inductor current higher than the over-current threshold. Also when the current is being limited, the output voltage tends to fall as the demanded load current may be higher than the current available from the converter. When the over current condition is removed, the output voltage returns to the regulated value. This protection is non-latching.

#### **Undervoltage Protection and Hiccup Mode**

Hiccup mode of operation protects the power supply from being damaged during an over-current fault condition. If the OCL comparator circuit detects an over-current event the output voltage falls. When the feedback voltage falls below 68% of the reference voltage, the UVP comparator output goes high and an internal UVP delay counter begins counting. After counting UVP delay time, the TPS54495 shuts off the power supply for a given time (7x UVP Enable Delay Time) and then tries to re-start the power supply. If the over-load condition has been removed, the power supply starts and operates normally; otherwise, the TPS54495 detects another over-current event and shuts off the power supply again, repeating the previous cycle. Excess heat due to overload lasts for only a short duration in the hiccup cycle, therefore the junction temperature of the power device is much lower.

#### **UVLO Protection**

Under-voltage lock out protection (UVLO) monitors the voltage of the  $V_{REG5}$  pin. When the  $V_{REG5}$  voltage is lower than the UVLO threshold, the TPS54495 shuts down. As soon as the voltage increases above the UVLO threshold, the converter starts again.

#### **Thermal Shutdown**

TPS54495 monitors its temperature. If the temperature exceeds the threshold value (typically 155°C), the device shuts down. When the temperature falls below the threshold, the IC starts again.

When VIN1 starts up and VREG5 output voltage is below its nominal value, the thermal shutdown threshold is lower than 155°C. As long as VIN1 rises,  $T_J$  must be kept below 110°C.



50

45

40

35

30

25

20

15

10

5

0

EN Input Current (µA)

#### TYPICAL CHARACTERISTICS

One output is enabled unless otherwise noted.  $V_{IN} = VIN1$  or VIN2.  $V_{INx} = 12$  V,  $T_A = 25$ °C (unless otherwise noted).

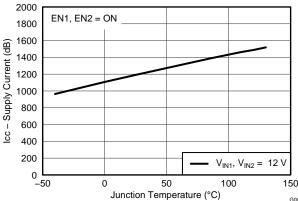
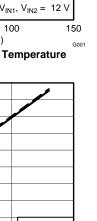


Figure 1. Input Current vs Junction Temperature



EN1

EN2

Product Folder Links: TPS54495

EN Input Voltage (V) Figure 3. EN Current vs EN Voltage (VEN=12V)

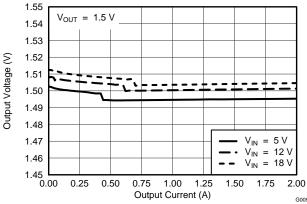


Figure 5. VO2=1.5V Output Voltage vs Output Current

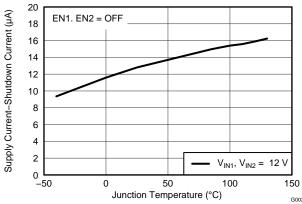


Figure 2. Input Shutdown Current vs Junction Temperature

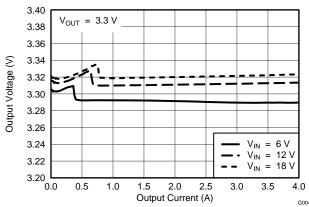


Figure 4. VO1=3.3V Output Voltage vs Output Current

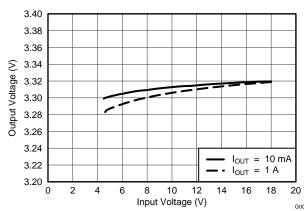


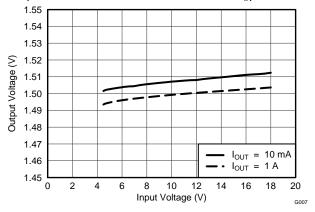
Figure 6. VO1=3.3V Output Voltage vs Input Voltage

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### TYPICAL CHARACTERISTICS (continued)

One output is enabled unless otherwise noted.  $V_{IN} = VIN1$  or VIN2.  $V_{INx} = 12$  V,  $T_A = 25$ °C (unless otherwise noted).



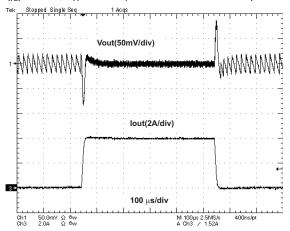
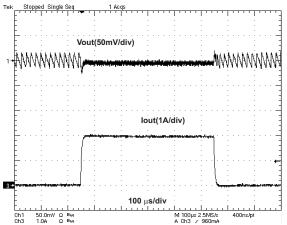
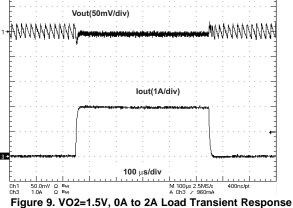


Figure 7. VO2=1.5V Output Voltage vs Input Voltage

Figure 8. VO1=3.3V, 0A to 4A Load Transient Response





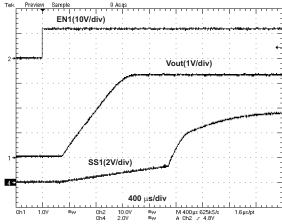
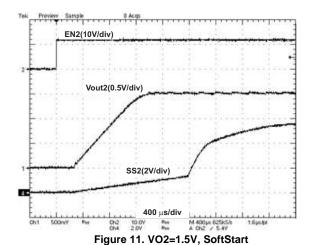


Figure 10. VO1=3.3V, SoftStart



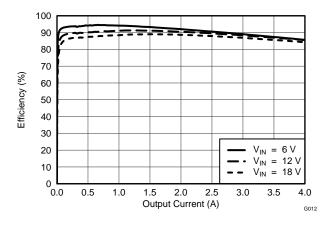


Figure 12. VO1=3.3V, Efficiency vs Output Current

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# TYPICAL CHARACTERISTICS (continued)

One output is enabled unless otherwise noted.  $V_{IN} = VIN1$  or VIN2.  $V_{INx} = 12$  V,  $T_A = 25$ °C (unless otherwise noted).

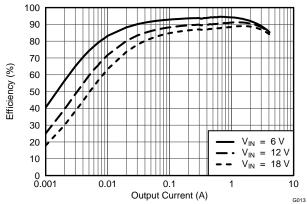
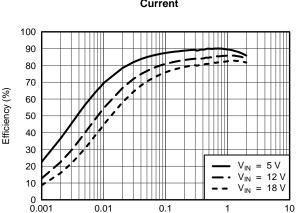


Figure 13. VO1=3.3V, Light Load Efficiency vs Output Current



Output Current (A) Figure 15. VO2=1.5V, Light Load Efficiency vs Output Current

0.1

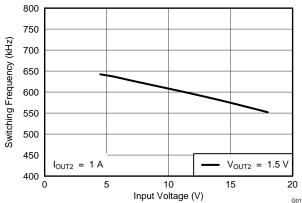


Figure 17. VO2=1.5V, SW-frequency vs Input Voltage

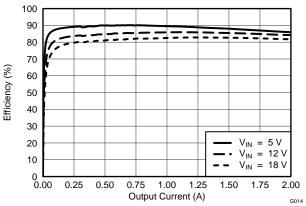


Figure 14. VO2=1.5V, Efficiency vs Output Current

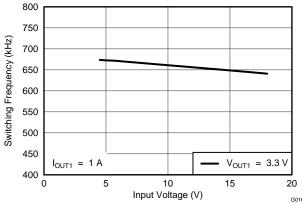


Figure 16. VO1=3.3V, SW-frequency vs Input Voltage

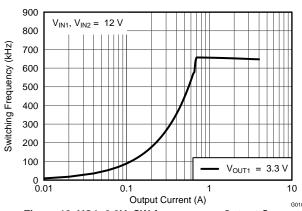
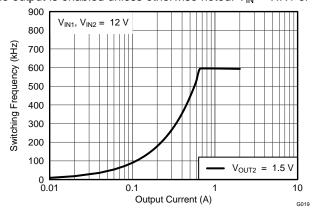


Figure 18. VO1=3.3V, SW-frequency vs Output Current



# TYPICAL CHARACTERISTICS (continued)

One output is enabled unless otherwise noted.  $V_{IN} = VIN1$  or VIN2.  $V_{INx} = 12$  V,  $T_A = 25$ °C (unless otherwise noted).



Tek Stopped Single Seq 1 Acqs

Vo = 3.3 V

Vo1(10mV/div)

SW1(5V/div)

2

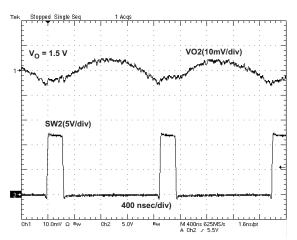
400 nsec/div)

A 00ns 625M5/s 1.8ns/px

A Ch2 4 45/6 4 45/6 1.8ns/px

Figure 19. VO2=1.5V, SW-frequency vs Output Current

Figure 20. VO1=3.3V, VO1 Ripple Voltage (I<sub>O1</sub>= 4 A)



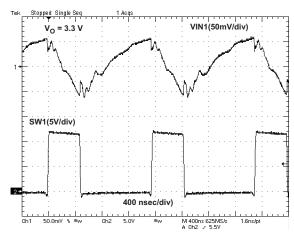


Figure 21. VO2=1.5V, Ripple Voltage (I<sub>O2</sub>= 2 A)

Figure 22. VIN1 Input Voltage Ripple (I<sub>O1</sub>= 4 A)

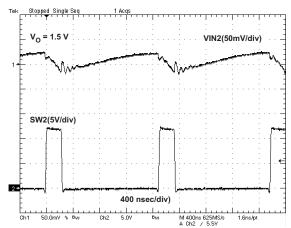


Figure 23. VIN2 Input Voltage Ripple (I<sub>O2</sub>= 2 A)

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#### **DESIGN GUIDE**

### **Step By Step Design Procedure**

To begin the design process, you must know a few application parameters:

- Input voltage range
- Output voltage
- Output current

In all formulas x is used to indicate that they are valid for both converters. For the calculations the estimated switching frequency of 700 kHz is used.

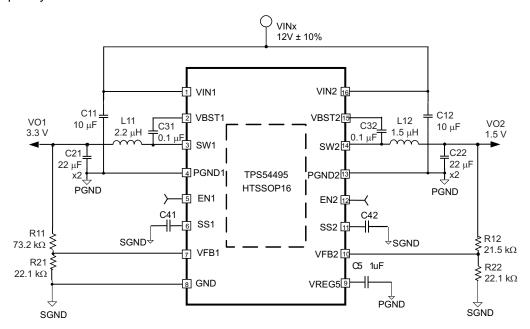


Figure 24. Schematic Diagram for the Design Example

# **Output Voltage Resistors Selection**

The output voltage is set with a resistor divider from the output node to the VFBx pin. It is recommended to use 1% tolerance or better divider resistors. Start by using Equation 3 to calculate  $V_{Ox}$ .

To improve the efficiency at very light loads consider using larger value resistors, but too high resistance values will be more susceptible to noise and voltage errors due to the VFBx input current will be more noticeable.

$$V_{Ox} = 0.765 \text{ V} \times \left(1 + \frac{\text{R1x}}{\text{R2x}}\right) \tag{3}$$

### **Output Filter Selection**

The output filter used with the TPS54495 is an LC circuit. This LC filter has double pole at:

$$F_{P} = \frac{1}{2\pi\sqrt{L1x \times C1x}} \tag{4}$$



At low frequencies, the overall loop gain is set by the output set-point resistor divider network and the internal gain of the TPS545495. The low frequency phase is 180 degrees. At the output filter pole frequency, the gain rolls off at a −40 dB per decade rate and the phase drops rapidly. D-CAP2™ introduces a high frequency zero that reduces the gain roll off to −20 dB per decade and increases the phase to 90 degrees one decade above the zero frequency. The inductor and capacitor selected for the output filter must be selected so that the double pole of Equation 4 is located below the high frequency zero but close enough that the phase boost provided by the high frequency zero provides adequate phase margin for a stable circuit. To meet this requirement use the values recommended in Table 1.

**Table 1. Recommended Component Values** 

Output Voltage (V)	R1x (kΩ)	R2x (kΩ)	Cffx (pF) <sup>(1)</sup>	L1x (µH)	C2x (µF)
1	6.81	22.1		1.5 - 2.2	20 - 68
1.05	8.25	22.1		1.5 - 2.2	20 - 68
1.2	12.7	22.1		1.5 - 2.2	20 - 68
1.5	21.5	22.1		1.5 - 2.2	20 - 68
1.8	30.1	22.1	5 - 22	2.2 - 3.3	20 - 68
2.5	49.9	22.1	5 - 22	2.2 - 3.3	20 - 68
3.3	73.2	22.1	5 - 22	2.2 - 3.3	20 - 68
5	124	22.1	5 - 22	4.7	20 - 68
6.5	165	22.1	5 - 22	4.7	20 - 68

#### (1) Optional

For higher output voltages at or above 1.8 V, additional phase boost can be achieved by adding a feed forward capacitor (Cffx) in parallel with R1x.

The inductor peak-to-peak ripple current, peak current and RMS current are calculated using Equation 5, Equation 6 and Equation 7. The inductor saturation current rating must be greater than the calculated peak current and the RMS or heating current rating must be greater than the calculated RMS current.

For the calculations, use 700 kHz as the switching frequency, f<sub>SW</sub>. Make sure the chosen inductor is rated for the peak current of Equation 6 and the RMS current of Equation 7.

$$\Delta I_{L1x} = \frac{V_{Ox}}{V_{INx(MAX)}} \times \frac{V_{INx(MAX)} - V_{Ox}}{L1x \times f_{SW}}$$
(5)

$$I_{L1xpeak} = I_{Ox} + \frac{\Delta I_{L1x}}{2}$$
 (6)

$$I_{L1x(RMS)} = \sqrt{I_{Ox}^2 + \frac{1}{12} \Delta I_{L1x}^2}$$
 (7)

For the above design example, the calculated peak current is 4.46 A and the calculated RMS current is 4.01 A for VO2. The inductor used is a TDK CLF7045T-2R2N with a rated current of 5.5A based on the inductance change, and of 4.3A based on the temperature rise.

The capacitor value and ESR determines the amount of output voltage ripple. The TPS54495 is intended for use with ceramic or other low ESR capacitors. The recommended value range is from 20µF to 68µF. Use Equation 8 to determine the required RMS current rating for the output capacitor(s).

$$I_{C2x(RMS)} = \frac{V_{Ox} \times (V_{INx} - V_{Ox})}{\sqrt{12} \times V_{INx} \times L1x \times f_{SW}}$$
(8)

For this design two TDK C3216X5R0J226M 22 $\mu$ F output capacitors are used. The typical ESR is 2 m $\Omega$  each. The calculated RMS current is 0.19A and each output capacitor is rated for 4A.



### **Input Capacitor Selection**

The TPS54495 requires an input decoupling capacitor and a bulk capacitor is needed depending on the application. A ceramic capacitor of or above  $10\mu\text{F}$  is recommended for the decoupling capacitor. Additionally, 0.1  $\mu\text{F}$  ceramic capacitors from pin 1 and Pin 16 to ground are recommended to improve the stability and reduce the SWx node overshoots. The capacitors voltage rating needs to be greater than the maximum input voltage.

### **Bootstrap Capacitor Selection**

A 0.1 µF ceramic capacitors must be connected between the VBSTx and SWx pins for proper operation. It is recommended to use ceramic capacitors with a dielectric of X5R or better.

### **VREG5 Capacitor Selection**

A 1 µF ceramic capacitor must be connected between the VREG5 and GND pins for proper operation. It is recommended to use a ceramic capacitor with a dielectric of X5R or better.

#### Thermal Information

This 16-pin PWP package incorporates an exposed thermal pad. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB is used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the exposed thermal pad and how to use the advantage of its heat dissipating abilities, refer to the Technical Brief, *PowerPAD™ Thermally Enhanced Package*, Texas Instruments Literature No. SLMA002 and Application Brief, *PowerPAD™ Made Easy*, Texas Instruments Literature No. SLMA004.

The exposed thermal pad dimensions for this package are shown in the following illustration.

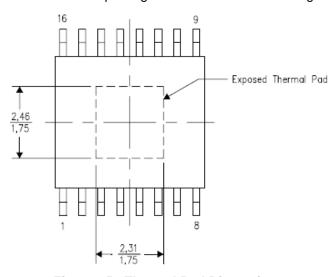


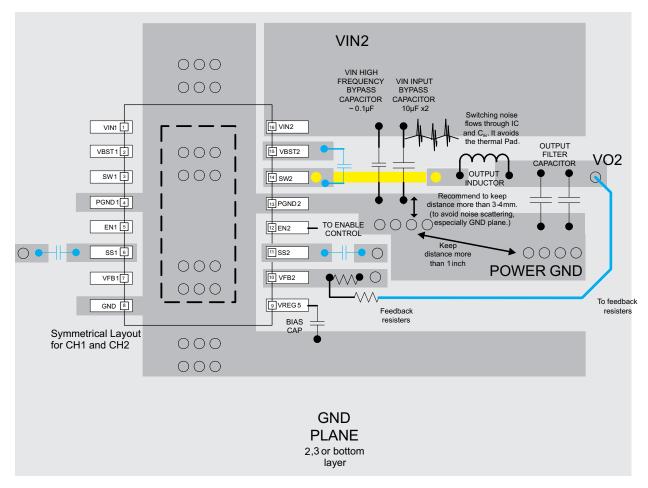
Figure 25. Thermal Pad Dimensions

#### **Layout Considerations**

- 1. Keep the input current loop as small as possible. And avoid the input switching current through the thermal pad.
- 2. Keep the SW node as physically small and short as possible to minimize parasitic capacitance and inductance and to minimize radiated emissions.
- 3. Keep analog and non-switching components away from switching components.
- 4. Make a single point connection from the signal ground to power ground.
- 5. Do not allow switching currents to flow under the device.
- 6. Keep the pattern lines for VINx and PGNDx broad.



- 7. Exposed pad of device must be soldered to PGND.
- 8. VREG5 capacitor should be placed near the device, and connected to GND.
- 9. Output capacitors should be connected with a broad pattern to the PGND.
- 10. Voltage feedback loops should be as short as possible, and preferably with ground shields.
- 11. Kelvin connections should be brought from the output to the feedback pin of the device.
- 12. Providing sufficient vias is preferable for VIN, SW and PGND connections.
- 13. PCB pattern for VIN, SW, and PGND should be as broad as possible.
- 14. VIN Capacitor should be placed as near as possible to the device.



# ○ Via to GND Plane

- Blue parts can be placed on the bottom side
- Connect the SWx pins through another layer with the inductor (yellow line)

Figure 26. TPS54495 PWP Package Layout



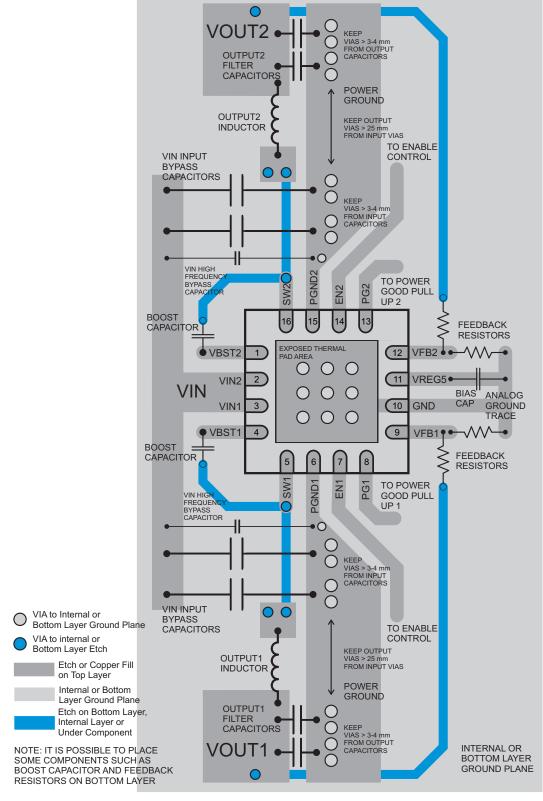


Figure 27. RSA Package Layout



# **REVISION HISTORY**

С	Changes from Original (June 2012) to Revision A	Page
•	Added 16-pin VQFN package to the Features and Description	1
•	Added the RSA 16 pin package to the Ordering Information table	2
•	Added the RSA package to the Thermal Information table	2
•	Added the RSA 16 pin package pinout image, pin names and functions to the DEVICE INFORMATION section	5
•	Added Figure 27	17

Product Folder Links: TPS54495

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4-Jul-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	_	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
TPS54495PWP	ACTIVE	HTSSOP	PWP	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PS54495	Samples
TPS54495PWPR	ACTIVE	HTSSOP	PWP	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	PS54495	Samples
TPS54495RSAR	ACTIVE	QFN	RSA	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TPS 54495	Samples
TPS54495RSAT	ACTIVE	QFN	RSA	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TPS 54495	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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# **PACKAGE OPTION ADDENDUM**

4-Jul-2013

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PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS54495PWPR	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TPS54495RSAR	QFN	RSA	16	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TPS54495RSAT	QFN	RSA	16	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

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\*All dimensions are nominal

7 til alliforiolorio aro fiorilifiai							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS54495PWPR	HTSSOP	PWP	16	2000	367.0	367.0	35.0
TPS54495RSAR	QFN	RSA	16	3000	367.0	367.0	35.0
TPS54495RSAT	QFN	RSA	16	250	210.0	185.0	35.0

PWP (R-PDSO-G16)

# PowerPAD™ PLASTIC SMALL OUTLINE



NOTES:

- All linear dimensions are in millimeters.
- This drawing is subject to change without notice.
- Body dimensions do not include mold flash or protrusions. Mold flash and protrusion shall not exceed 0.15 per side.
- This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <a href="http://www.ti.com">www.ti.com</a>.

  E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- E. Falls within JEDEC MO-153

PowerPAD is a trademark of Texas Instruments.



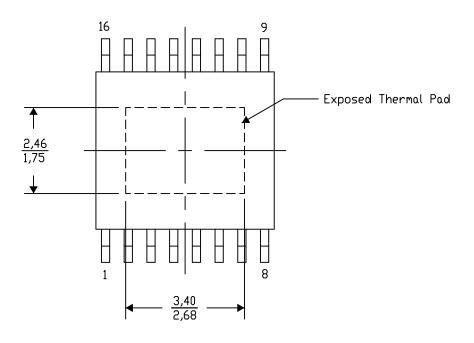
# PWP (R-PDSO-G16) PowerPAD™ SMALL PLASTIC OUTLINE

#### THERMAL INFORMATION

This PowerPAD<sup>™</sup> package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View

Exposed Thermal Pad Dimensions

4206332-7/AF 06/13

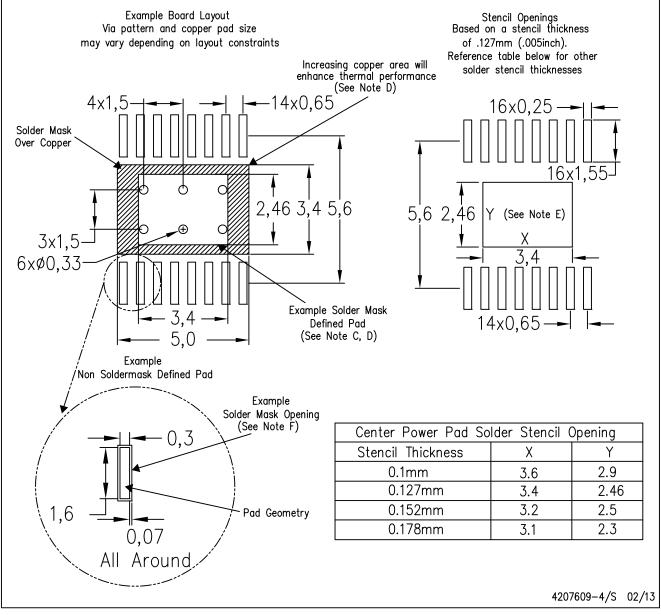
NOTE: A. All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments



# PWP (R-PDSO-G16)

# PowerPAD™ PLASTIC SMALL OUTLINE



#### NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# RSA (S-PVQFN-N16)

# PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

- B. This drawing is subject to change without notice.
- C. Quad Flatpack, No—leads (QFN) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F. Falls within JEDEC MO-220.



4206364/N 07/13

# RSA (S-PVQFN-N16)

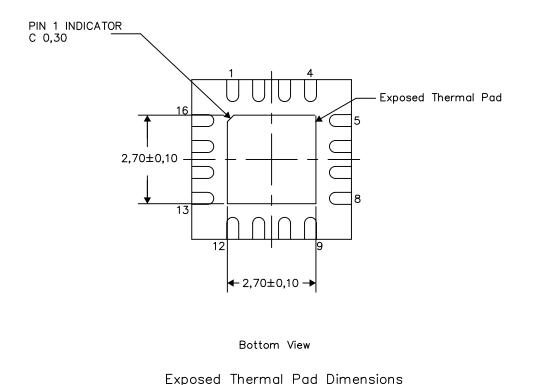
PLASTIC QUAD FLATPACK NO-LEAD

# THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



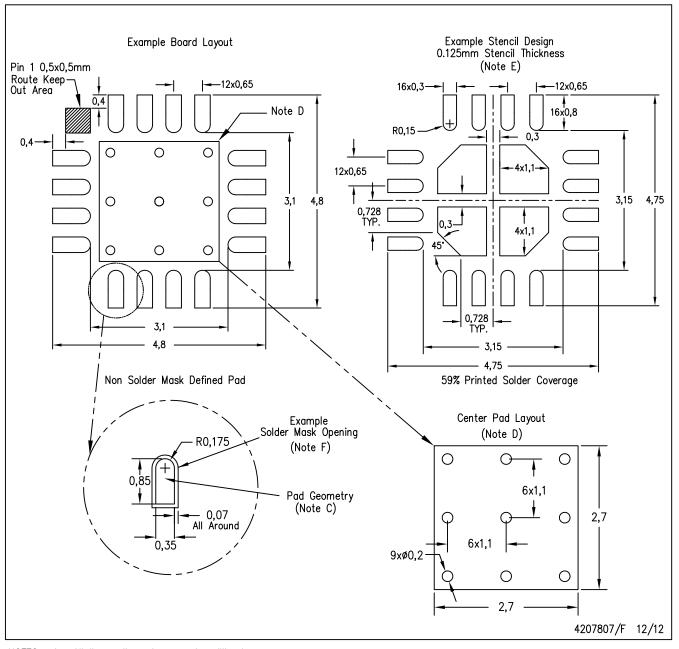
NOTES:

A. All linear dimensions are in millimeters



# RSA (S-PVQFN-N16)

# PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for solder mask tolerances.



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